

AO6402A

N-Channel Enhancement Mode Field Effect Transistor



General Description

The AO6402A uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance. Standard Product AO6402A is Pb-free (meets ROHS & Sony 259 specifications).

Features

 $V_{DS}(V) = 30V$

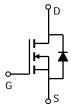
 $I_D = 7A$ $(V_{GS} = 10V)$

 $R_{DS(ON)}$ < 27m Ω (V_{GS} = 10V)

 $R_{DS(ON)} < 40 \text{m}\Omega$ (V_{GS} = 4.5V)

Rg,Ciss,Coss,Crss Tested!

TSOP-6 Top View



Absolute Maximum Ratings T_A =25°C unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _A =25°C		7.0		
Current A,F	T _A =70°C	I_D	5.6	Α	
Pulsed Drain Current ^B		I_{DM}	30		
	T _A =25°C	P_D	2.0	W	
Power Dissipation	T _A =70°C]' D	1.28	VV	
Junction and Storage Temperature Range		T_J , T_{STG}	-55 to 150	°C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s	$R_{\theta JA}$	48	62.5	°C/W			
Maximum Junction-to-Ambient ^A	Steady-State	IN _θ JA	74	110	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	35	40	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V				1	μА		
			T _J =55°C			5	μΛ		
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_D=250\mu A$		1	1.6	2.5	V		
$I_{D(ON)}$	On state drain current	V _{GS} =10V, V _{DS} =5V		30			Α		
	Static Drain-Source On-Resistance	V_{GS} =10V, I_{D} =7A			22.5	27	mΩ		
$R_{DS(ON)}$			T _J =125°C		32	39	11152		
		V_{GS} =4.5V, I_{D} =5.6A			32.5	40	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =7A			20		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.75	1	٧		
Is	Maximum Body-Diode Continuous Current					2.5	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			621	820	pF		
Coss	Output Capacitance				118		pF		
C _{rss}	Reverse Transfer Capacitance				85		pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			0.8	1.5	Ω		
SWITCHI	NG PARAMETERS								
Q _g (10V)	Total Gate Charge				11.3	17	nC		
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =7A			5.7	8	nC		
Q_{gs}	Gate Source Charge				2.1		nC		
Q_{gd}	Gate Drain Charge				3		nC		
t _{D(on)}	Turn-On DelayTime				4.5	6.5	ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =2.6 Ω , R_{GEN} =3 Ω			3.1	5	ns		
t _{D(off)}	Turn-Off DelayTime				15.1	23	ns		
t _f	Turn-Off Fall Time				2.7	5	ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =7A, dI/dt=100A/μs			15.5	21	ns		
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =7A, dI/dt=100A/μs			7.1	10	nC		

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the $t \le 10$ s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

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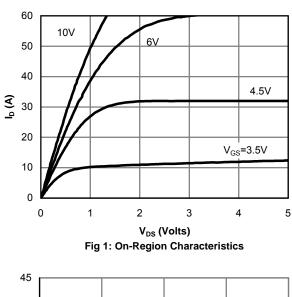
C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

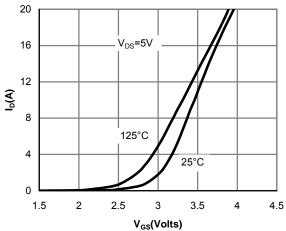
D. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

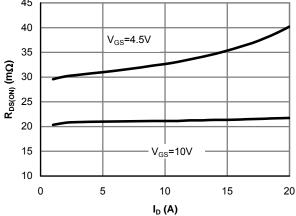
F.The current rating is based on the $t \le 10s$ thermal resistance rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS









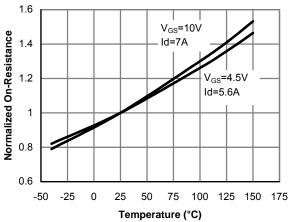
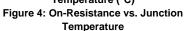
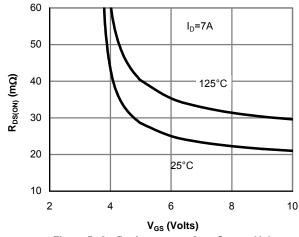


Figure 3: On-Resistance vs. Drain Current and Gate Voltage





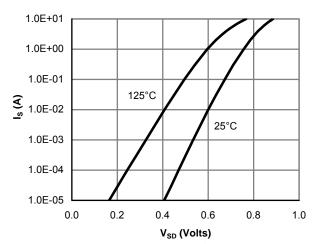


Figure 5: On-Resistance vs. Gate-Source Voltage

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

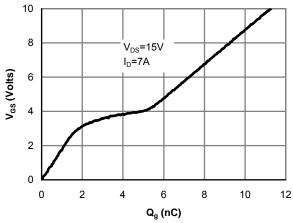


Figure 7: Gate-Charge Characteristics

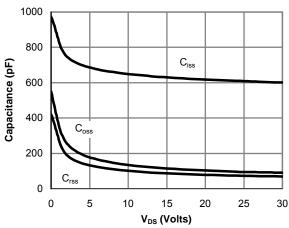


Figure 8: Capacitance Characteristics

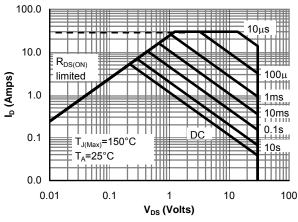


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

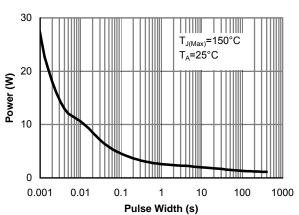


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

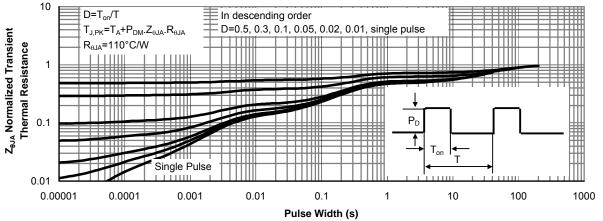


Figure 11: Normalized Maximum Transient Thermal Impedance